

REMARKS

Applicants wish to thank Examiner Liu for the indication that Claims 1-3 and 5-11 are allowed in the present application.

During a review of the present application, Applicants have noted several minor errors introduced by way of Examiner's Amendment and appearing in Claims 1, 2, and 9. Specifically, Applicants noted that Claims 1 and 9 improperly recited "in the regions from  $\alpha_2$  to  $\beta_2$  and from the region from  $\beta_3$  to  $\beta_4$ " this phrase should be amended as follows: "in the ~~regions~~ region from  $\alpha_2$  to  $\beta_2$  and ~~from~~ the region from  $\beta_3$  to  $\beta_4$ ." Similarly, in Claim 6 the phrase "in the regions from  $\alpha_2$  to  $\beta_2$  and the region from  $\beta_3$  to  $\beta_4$ " should be amended as follows: "in the ~~regions~~ region from  $\alpha_2$  to  $\beta_2$  and the region from  $\beta_3$  to  $\beta_4$ ."

No new matter has been entered by the present amendment. Moreover, since the amendments herein relate to dependent claims only and are grammatical in nature, Applicants believe that the amendments herein do not raise any new issues of patentability.

Applicants note that in the Examiner's Amendment dated February 13, 2006, the Examiner has indicated several amendments to the specification. Specifically, the Examiner has indicated that there certain amendments are to be made with respect to the description of the drawings. Applicants confirm that these amendments are correct and accept the same.

Respectfully submitted,

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